

Application/Control No. 10/553,846	Applicant(s)/Patent under Reexamination LEE ET AL.
Examiner	Art Unit
TUYET VO	2821

				ISSUE	CL	.AS	SIF	ICATI	ON						
		ORIGINAL			INTERNATIONAL CLASSIFICATION										
	.ASS			CI	_AIMED		NO	NON-CLAIMED							
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	CRO	SS REFERE	NCES						,			,			
CLASS	SUBCLA	R BLOCK)					,			1					
315 224 291		291	307	274					/			1			
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(Assi	/TUYE	T VC)/ /*	1/30/2	2008/	Total Claims Allowed: 26									
(Legal In:	struments E	Examiner)	(Date)	(Primary			- /	(Date)		O.G. Print Fig.					
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	Claims renumbered in the same order as presented by applicant								□СРА		☐ T.D.		☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	Final	Original		Final	Original
1	1			31			61]		91			121		151			181
13	2			32			62			92			122		152			182
14	3]		33			63]		93			123		153			183
15	4]		34			64]		94			124		154			184
5	5			35			65			95			125		155			185
6	6			36			66			96			126		156			186
2	7]		37			67]		97			127		157			187
3	8			38			68			98			128		158			188
4	9			39			69			99			129		159			189
16	10			40			70			100			130		160			190
17	11	J		41			71]		101			131		161			191
18	12			42			72			102			132		162			192
19	13	Į		43			73	Į		103			133		163			193
20	14]		44			74]		104			134		164			194
21	15	ļ		45			75	ļ		105			135		165			195
22	16]		46			76			106			136		166			196
23	17]		47			77	[107			137		167			197
24	18			48			78			108			138		168			198
25	19]		49			79]		109			139		169			199
9	20]		50			80			110			140		170			200
11	21	ļ		51			81	ļ		111			141		171			201
10	22]		52			82			112			142		172			202
12	23]		53			83			113			143		173			203
7	24	J		54			84]		114			144		174			204
8	25]		55			85]		115			145		175			205
0	26	ļ		56			86	[116			146		176			206
26	27]		57			87]		117			147		177			207
	28]		58			88]		118			148		178			208
	29]		59			89]		119			149		179			209
	30			60			90			120			150		180			210